



## Proyecto Consolider-Ingenio 2010 “GENESIS-FV”

*Investigación en materia de una nueva generación de materiales,  
células y sistemas para la conversión fotovoltaica*

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Madrid 28/ 02/2011

### **Line L :**

## **Intermediate band materials by sputtering**

- **Milestones**
- **GaAs & GaAs (Ti) Sputtering processes**
- **Si(Ti) HiT solar cell**

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*Investigación en materia de una nueva generación de materiales, células y sistemas para la conversión fotovoltaica*

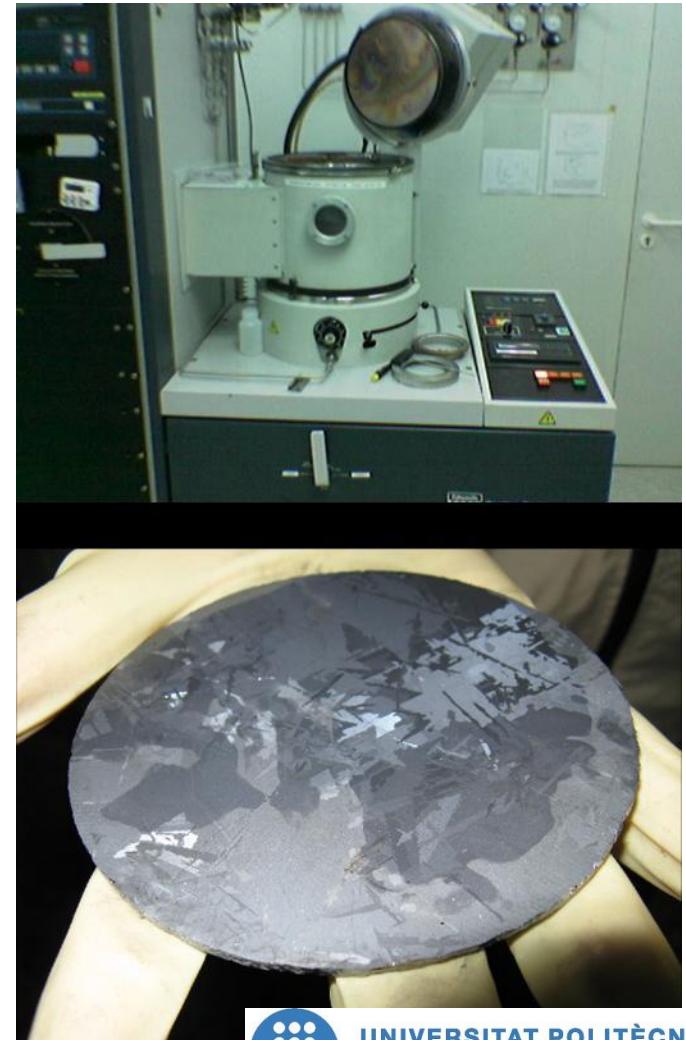


Line	Milestones year 3 (15/09/2009)	Degree of fulfilment (14/09/2009)	Milestones year 5 (15/09/2011)	Degree of fulfilment (17/02/2010)
L Intermediate band material By Sputtering	IB Material	<p>1 patent at OEPM+ PCT</p> <p>P200800571: “Procedimiento para la obtención de Películas de Materiales Semiconductores Incorporando una Banda Intermedia”.</p>	<p>1 high impact paper</p>	<p>Communications at Conferences :</p> <ul style="list-style-type: none"> <li>- CDE 2009</li> <li>- IEEE PVSC 2010</li> <li>- CDE 2011</li> <li>- 1 Paper (TSF)</li> <li>- ( In review )</li> </ul>

### Collaboration in LINE M: Intermediate band solar cells in bulk material

# GaAs & GaAs (Ti) Sputtering processes

- Thin films have been deposited on glass substrates under different process conditions in a RF Sputtering System :ESM100 Edwards & RFS5 Generator-300W.
- Two different targets have been used in these processes:
  - GaAs (99.5%)-Ti (0.5%),  
Purity ; 99,999% ,  
Size: 4" Diameter x 0.125"
  - GaAs(n) <100>,  
having a Si impurity concentration  
of  $7 \times 10^{17} \text{ cm}^{-3}$   
Size: 4" Diameter x 400  $\mu\text{m}$



# GaAs & GaAs (Ti) Sputtering processes

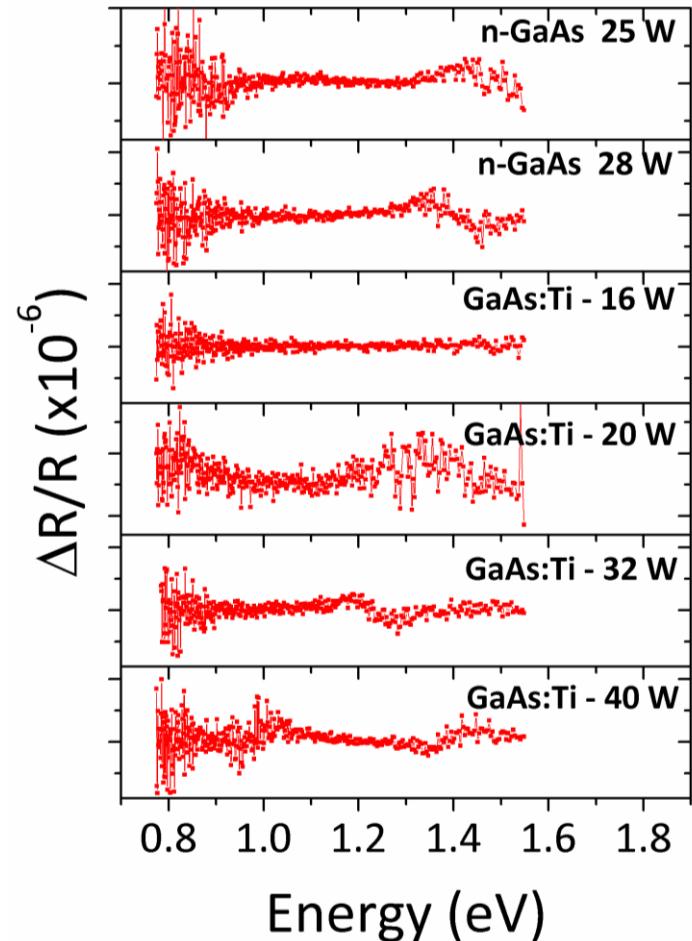
- Thin films of GaAs(Ti), ranging from 90nm to 250 nm thick, were grown by sputtering on glass substrates
  
- Sputtering Process conditions :
  - Chamber pressure  $5 \cdot 10^{-3}$  mbar
  - substrate temperature :  $30^{\circ}\text{C} - 400^{\circ}\text{C}$
  - Ar flux: **5,10 and 15 sccm**
  - R.F. input power ranging from **16 to 40 W**
  - Distance between target & sample : 6.5 cm
  - No sample Rotation along sputtering process



# GaAs & GaAs (Ti) Sputtering processes

PR-spectra obtained from the n-GaAs and GaAs(Ti) samples

- Residual crystallization of n-GaAs samples  
(PR-signature around 1.4 eV)
- The GaAs:Ti sample grown at 40 W shows two apparent signatures  
(1.4 eV and a 1.0 eV)

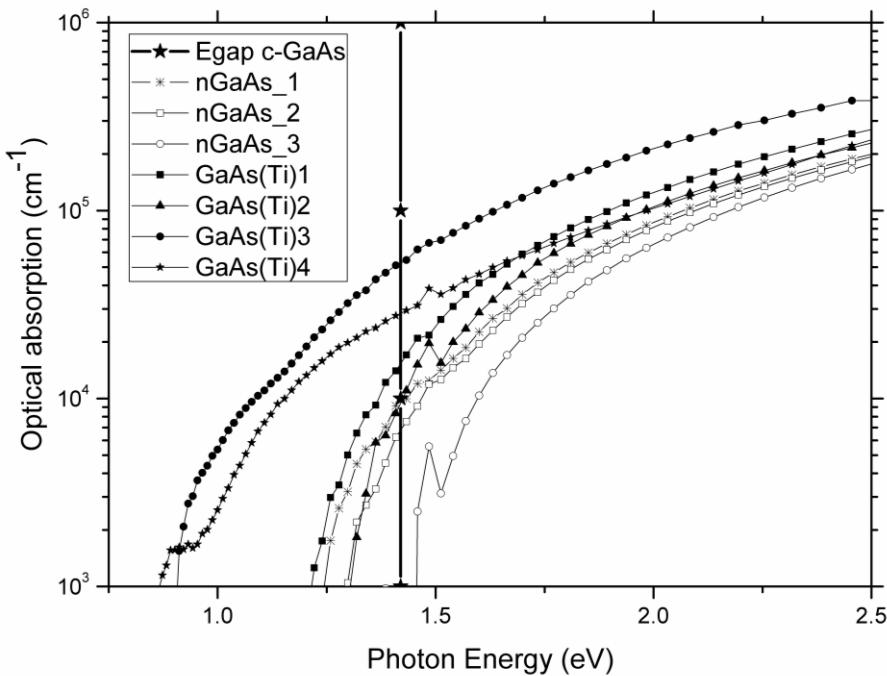


# GaAs & GaAs (Ti) Sputtering processes

Shimadzu



UV-VIS-NIR spectrophotometer



$$(\alpha \hbar v)^{1/2} = C_{\text{Tauc}} (\hbar v - E_{\text{Tauc}})$$

Sample	$Eg_{\text{Tauc}}$ (eV)	$C_{\text{Tauc}}$ ( $\text{cm}^{1/2} \text{eV}^{1/2}$ )	$\alpha(\text{cm}^{-1})$ lower limit	$\alpha(\text{cm}^{-1})$ upper limit
GaAs(Ti)1	1.12	982.86	$2.6 \cdot 10^5$	$9.96 \cdot 10^5$
GaAs(Ti)2	1.13	695.70	$1.38 \cdot 10^5$	$5.68 \cdot 10^5$
GaAs(Ti)3	0.99	679.55	$1.71 \cdot 10^5$	$3.47 \cdot 10^5$
GaAs(Ti)4	0.83	405.46	$8.72 \cdot 10^4$	$2.55 \cdot 10^5$
n_GaAs1	1.15	538.04	$1.4 \cdot 10^5$	$3.11 \cdot 10^5$
n_GaAs2	1.23	574.35	$6.62 \cdot 10^4$	$3.38 \cdot 10^5$
n_GaAs3	1.29	581.97	$5.03 \cdot 10^4$	$3.26 \cdot 10^5$

Optical Absorption is enhanced by Ti in all samples

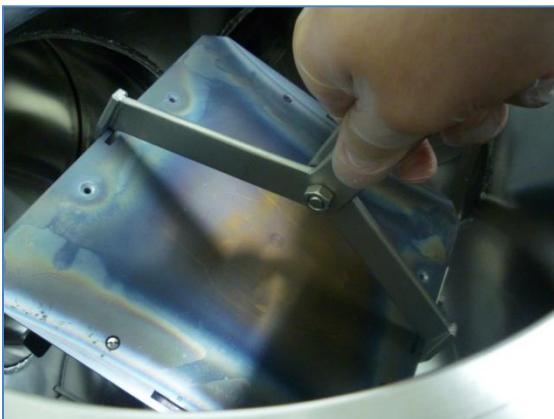
The differences in  $\alpha$  and  $Eg_{\text{Tauc}}$  between samples of n-GaAs and GaAs(Ti) are consistent with the presence of an intermediate band.

# Si(Ti) HiT Solar cel

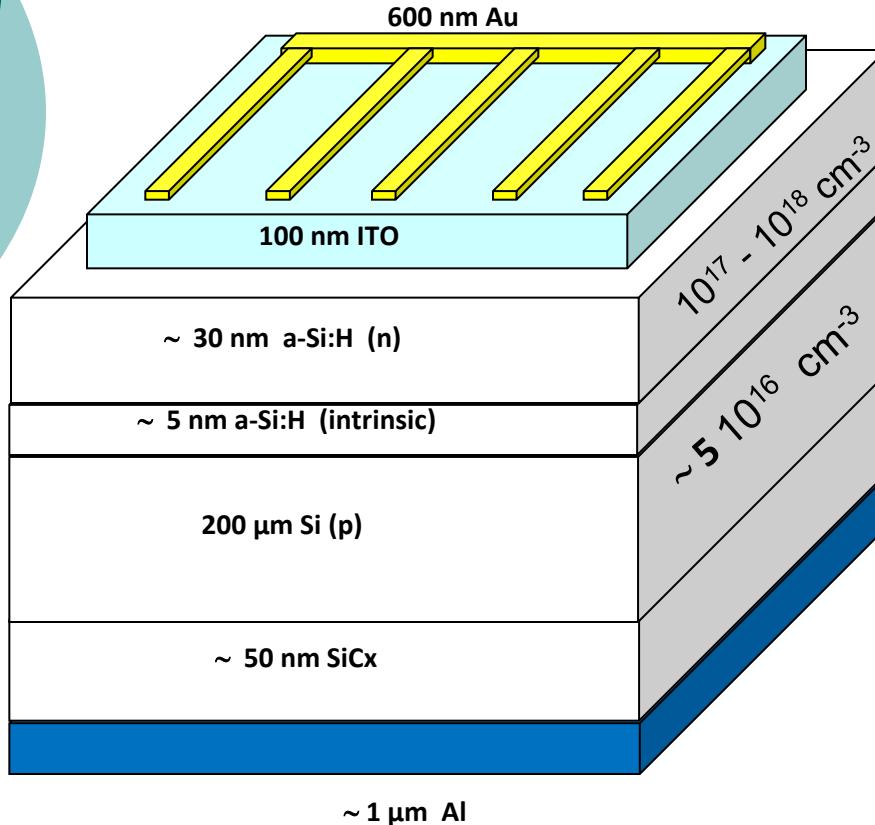
Hot-Wire CVD ?



Plasma-enhanced chemical vapor deposition PECVD



# Si(Ti) HIT Solar cell

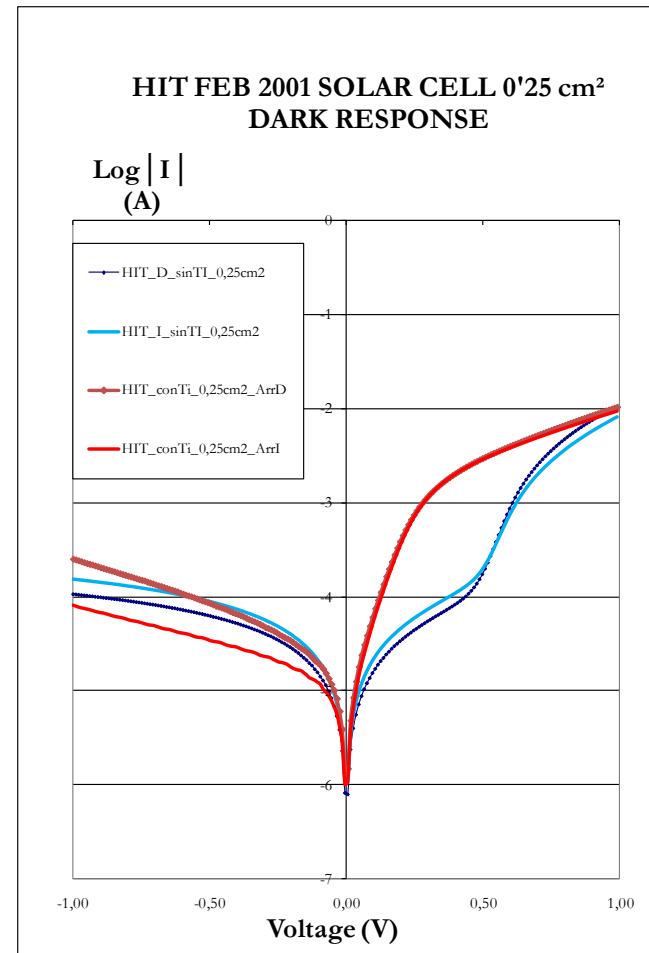
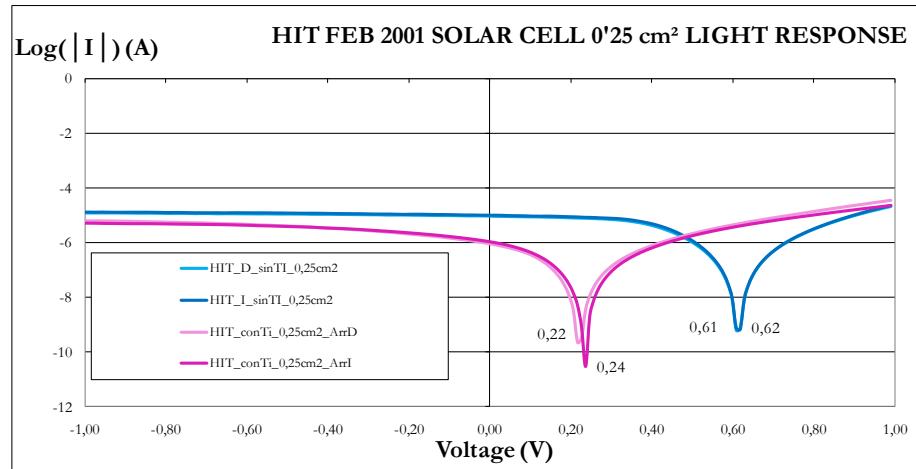
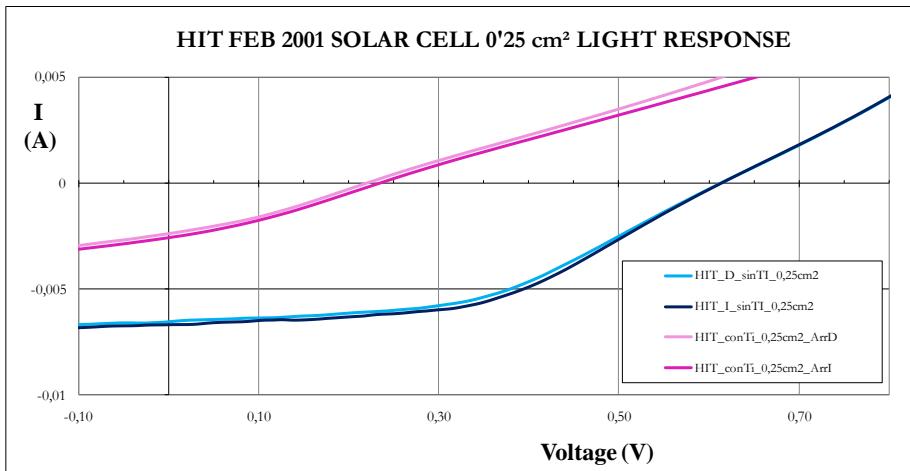
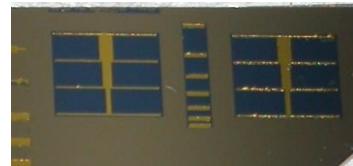


## Process Description

- Organic cleaning / HF cleaning
- Active layer deposition
  - a-Si:H intrinsic layer
  - Deposition of n doped a-Si:H layer
- Deposition of SiCx passivation layer
- Deposition of Al back ohmic contact (Thermal evaporation)
- Laser firing
- Deposition of ITO by R.F. Sputtering
- Lithography of ITO windows and etching
- Front contact Lithography**
- Front contact / Au R.F. Sputtering
- Lift-off

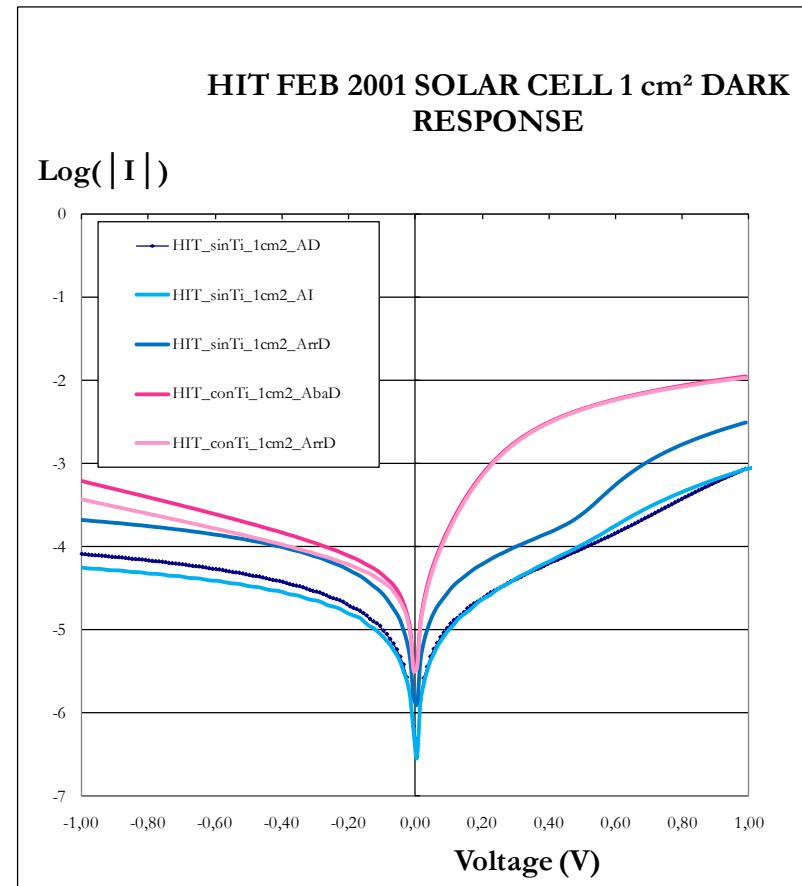
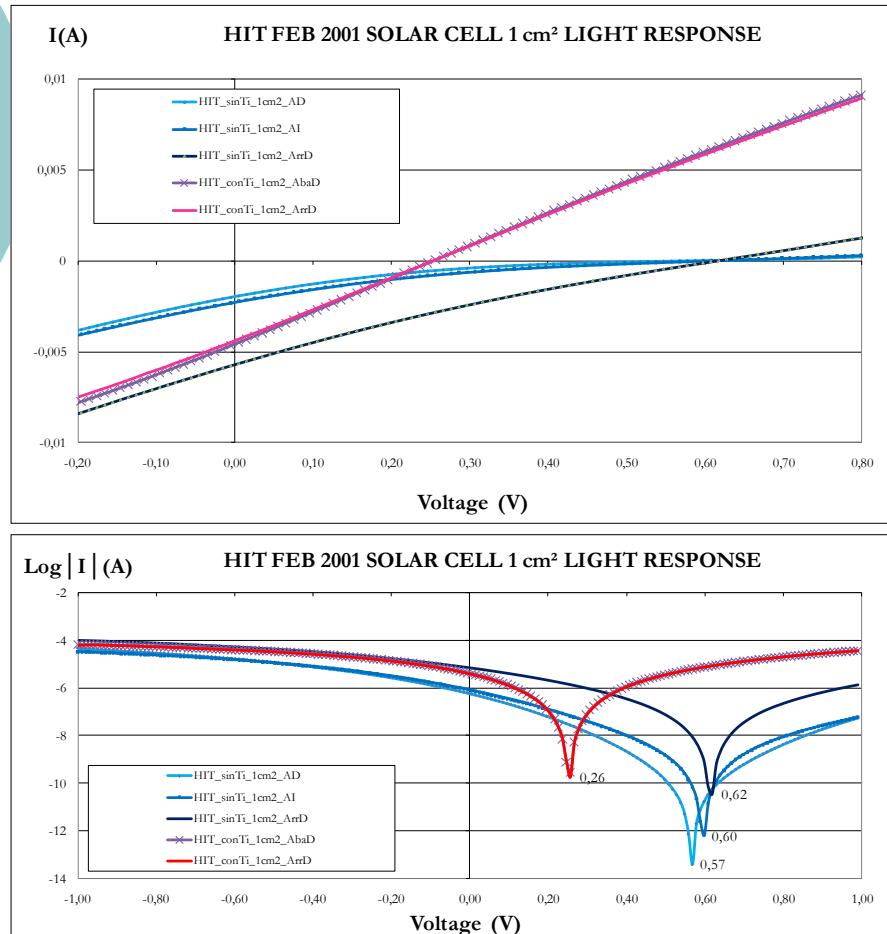
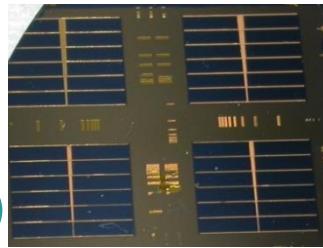
# Si(Ti) HiT Solar cell

(Area : 0.25 cm<sup>2</sup>)



# Si(Ti) HiT Solar cell

(Area :1 cm<sup>2</sup>)



# Conclusions

- Thin films of GaAs and GaAs(Ti) have been deposited by sputtering on glass under different process conditions. **Optical Absorption is enhanced by Ti in all samples**
- The differences in  $\alpha$  and EgTAUC between samples of n-GaAs and GaAs(Ti) are consistent with the presence of an **intermediate band**
- First Batch of **Si(Ti) HiT Solar cells Fabricated**
- New Batches of **Si(Ti) HiT, n\_GaAs/GaAs(Ti)/p:GaAs and n\_GaAs/GaAs(Ti)/p\_Si Solar cells will be fabricated**